

**Notice of References Cited**

Application/Control No.

09/811,994

Applicant(s)/Patent Under  
Reexamination  
OUESLATI ET AL.

Examiner

Sargon N Nano

Art Unit

2157

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5,684,988	11-1997	Pitchaikani et al.	707/104.1
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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